

**Notice of References Cited**

Application/Control No.

10/656,227

Applicant(s)/Patent Under  
Reexamination  
OGAWA, SOICHIRO

Examiner

Alix Elizabeth Echelmeyer

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,400,122	06-2002	Iwamura, Akira	320/107
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**NON-PATENT DOCUMENTS**

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